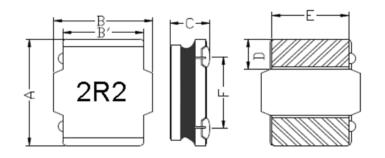
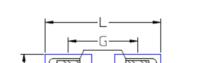


FEATRLRES

- This specification applies Low Profile Power Inductors.
- 100% Lead(Pb) & Halogen-Free and RoHS compliant.

CONFIGRLRATIONS & DIMENSIONS (unit in mm)





Recommended Land pattern

Туре	Α	В	B'	С	D	E	F
HNR6045NF	6.0±0.3	6.0±0.3	4.8±0.2	4.2±0.3	1.7±0.3	4.5±0.3	4.25±0.3

L	G	G1	Н
6.5	4.25	1.8min	4.8

Note:

- 1. The above PCB layout reference only.
- 2. Recommend solder paste thickness at 0.12mm and above.

ELECTRICAL CHARACTERISTICS

Inductance				Rated current					
Part Number	LO (uH)		Tole	erance	•	ure current s (A)	Saturatio I sat	n current t (A)	DCR (mΩ) @25℃ ±20%.
	w U A	K	L	M Y	Тур	Max	Тур	Max	120 70.
HNR6045NF-R36	0.36	/	/	±20% ±30%	9.00	8.50	18.00	16.50	4.80
HNR6045NF-R47	0.47	/	/	±20% ±30%	8.60	8.00	17.00	16.00	6.80
HNR6045NF-R82	0.82	/	/	±20% ±30%	8.20	7.50	14.50	13.50	8.50
HNR6045NF-1R0	1.00	/	/	±20% ±30%	8.00	7.30	13.50	12.50	10.0
HNR6045NF-1R2	1.20	/	/	±20% ±30%	7.50	7.00	12.50	11.50	10.5
HNR6045NF-1R3	1.30	/	/	±20% ±30%	7.50	7.00	12.50	11.50	10.5
HNR6045NF-1R5	1.50	/	/	±20% ±30%	7.00	6.60	12.00	11.00	11.7
HNR6045NF-1R8	1.80	/	/	±20% ±30%	6.80	6.20	11.00	10.00	12.0
HNR6045NF-2R0	2.00	/	/	±20% ±30%	6.50	5.80	10.50	9.50	13.5
HNR6045NF-2R2	2.20	/	/	±20% ±30%	6.00	5.30	9.50	8.55	15.0
HNR6045NF-2R3	2.30	/	/	±20% ±30%	5.80	5.00	9.30	8.20	16.0
HNR6045NF-3R0	3.00	/	/	±20% ±30%	5.20	4.60	8.00	7.50	20.0



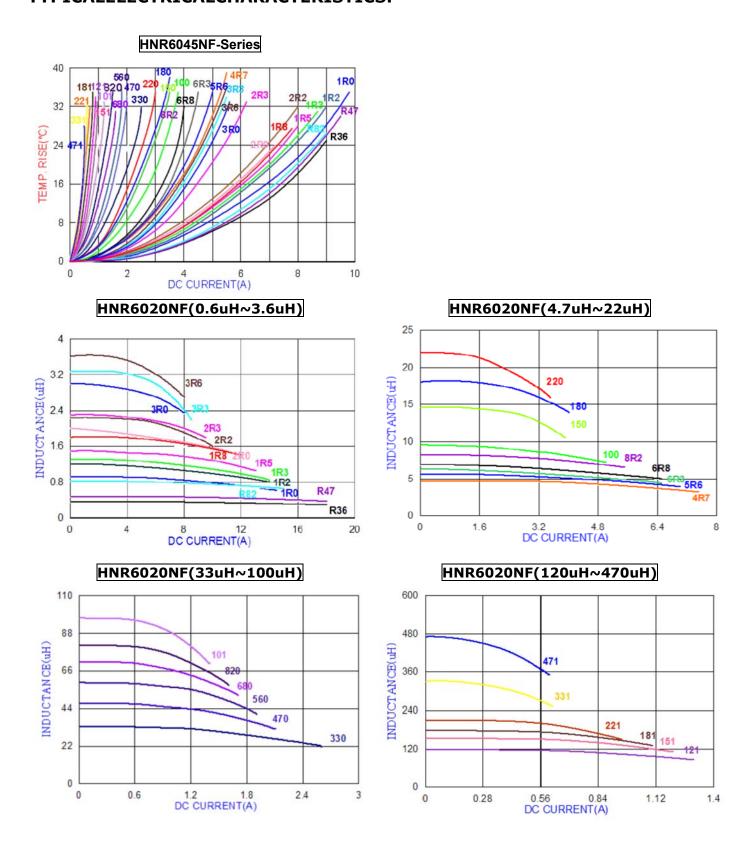
HNR6045NF-3R3	3.30	/ /	±20%	±30%	5.00	4.50	7.80	7.30	21.0
HNR6045NF-3R6	3.60	/ /	±20%	±30%	4.90	4.30	7.40	6.90	22.5
HNR6045NF-4R7	4.70	/ ±15%	% ±20%	±30%	4.50	4.00	6.80	6.20	26.0
HNR6045NF-5R6	5.60	/ ±15%	% ±20%	±30%	4.10	3.70	6.40	5.70	31.0
HNR6045NF-6R3	6.30	/ ±15%	% ±20%	±30%	3.80	3.50	5.90	5.30	33.0
HNR6045NF-6R8	6.80	/ ±15%	% ±20%	±30%	3.60	3.30	5.70	5.15	34.0
HNR6045NF-8R2	8.20	/ ±15%	% ±20%	±30%	3.40	2.90	5.10	4.50	46.0
HNR6045NF-100	10.0	±10% ±15%	% ±20%	±30%	3.20	2.60	4.60	4.20	52.0
HNR6045NF-150	15.0	±10% ±15%	% ±20%	±30%	2.80	2.20	3.80	3.30	71.0
HNR6045NF-180	18.0	±10% ±15%	% ±20%	±30%	2.60	2.10	3.40	2.90	80.0
HNR6045NF-220	22.0	±10% ±15%	% ±20%	±30%	2.30	1.90	3.30	2.70	96.0
HNR6045NF-330	33.0	±10% ±15%	% ±20%	±30%	1.80	1.50	2.50	2.10	145
HNR6045NF-470	47.0	±10% ±15%	% ±20%	±30%	1.60	1.20	2.00	1.75	200
HNR6045NF-560	56.0	±10% ±15%	% ±20%	±30%	1.40	1.00	1.80	1.65	230
HNR6045NF-680	68.0	±10% ±15%	% ±20%	±30%	1.10	0.92	1.60	1.52	305
HNR6045NF-820	82.0	±10% ±15%	% ±20%	±30%	0.98	0.88	1.50	1.40	365
HNR6045NF-101	100	±10% ±15%	% ±20%	±30%	0.92	0.82	1.33	1.25	456
HNR6045NF-121	120	±10% ±15%	% ±20%	±30%	0.85	0.79	1.20	1.10	500
HNR6045NF-151	150	±10% ±15%	% ±20%	±30%	0.75	0.70	1.10	1.00	626
HNR6045NF-181	180	±10% ±15%	% ±20%	±30%	0.68	0.60	1.00	0.90	745
HNR6045NF-221	220	±10% ±15%	% ±20%	±30%	0.60	0.50	0.88	0.77	900
HNR6045NF-331	330	±10% ±15%	% ±20%	±30%	0.55	0.45	0.60	0.55	1400
HNR6045NF-471	470	±10% ±15%	% ±20%	±30%	0.40	0.35	0.50	0.45	2050

Note:

- $2. Testing\ Instrument: HP4284A, CH11025, CH3302, CH1320\ , CH1320S\ LCR\ METER\ /\ Rdc: CH502BC\ MICRO\ OHMMETER.$
- 3.Heat Rated Current (Irms) will cause the coil temperature rise approximately Δt of 40°C.
- 4. Saturation Current (Isat) will cause L0 to drop approximately 30%.
- 5.The part temperature (ambient + temp rise) should not exceed 125° Cunder worst case operating conditions. Circuit design, component, PCB trace size and thickness, airflow and other cooling provisions all affect the part temperature. Part temperature should be verified in the end application.
- 6. Special inquiries besides the above common used types can be met on your requirement.



TYPICALELECTRICALCHARACTERISTICS:





Reliability and Test Condition

Item	Performance	Test Condition						
Operating temperature	-40~+125℃ (Including self - temperature rise)							
Storage temperature	110~+40°ℂ,50~60%RH (Product with taping) 240~+125°ℂ (on board)							
Electrical Performance Test								
Inductance	Refer to standard electrical characteristics list.	HP4284A,CH11025,CH3302,CH1320,CH1320S LCR Meter.						
DCR	Nelet to statitudi di electrical di raracteristics ilst.	CH16502,Agilent33420A Micro-Ohm Meter.						
Saturation Current (Isat)	Approximately△L30%	Saturation DC Current (Isat) will cause L0 to drop $\triangle L(\%)$						
Heat Rated Current (Irms)	Approximately △T40°C	Heat Rated Current (Irms) will cause the coil temperature rise $\triangle T(\mathbb{C})$. 1.Applied the allowed DC current 2.Temperature measured by digital surface thermometer						
Reliability Test								
Life Test		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles) Temperature: 125±2°C (Inductor) Applied current: rated current Duration: 1000±12hrs Measured at room temperature after placing for 24±2 hrs						
Load Humidity		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles Humidity: 85±2 * R.H, Temperature: 85°C±2°C Duration: 1000hrs Min. with 100% rated current Measured at room temperature after placing for 24±2 hrs						
Moisture Resistance	Appearance: No damage. Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value	Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles 1. Baked at50°C for 25hrs, measured at room temperature after placing for 4 hrs. 2. Raise temperature to 65±2°C 90-100%RH in 2.5hrs, and keep 3 hours, cool down to 25°C in 2.5hrs. 3. Raise temperature to 65±2°C 90-100%RH in 2.5hrs, and keep 3 hours, cool down to 25°C in 2.5hrs,keep at 25°C for 2 hrs then keep at -10°C for 3 hrs 4. Keep at 25°C 80-100%RH for 15min and vibrate at the frequency of 10 to 55 Hz to 10 Hz, measure at room temperature after placing for 1~2 hrs.						
Thermal shock Vibration		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles Condition for 1 cycle Step1: -40±2°C 30±5min Step2: 25±2°C ≤0.5min Step3: 125±2°C 30±5min Number of cycles: 500 Measured at room temperature after placing for 24±2 hrs Oscillation Frequency: 10 ~ 2K ~ 10Hz for 20 minutes Equipment: Vibration checker						
		Total Amplitude:1.52mm±10% Testing Time: 12 hours(20 minutes, 12 cycles each of 3 orientations). Shall be mounted on a FR4 substrate of the						
Bending		following dimensions: >=0805 inch(2012mm):40x100x1.2mm <0805 inch(2012mm):40x100x0.8mm Bending depth: >=0805 inch(2012mm):1.2mm <0805 inch(2012mm):0.8mm duration of 10 sec.						
Shock	Appearance: No damage. Impedance: within±15% of initial value Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value	Type Peak value (g's) Normal duration (D) (ms) Wave form Velocity change (Vi)ft/sec SMD 50 11 Half-sine 11.3 Lead 50 11 Half-sine 11.3						
Solder ability	Preheat: 150℃,60sec.。 More than 95% of the terminal electrode should be covered with solder。 Solder: Sn96.5% Ag3% Cu0.5% Temperature: 245±5℃。 Flux for lead free: Rosin. 9.5%。 Dip time: 4±1sec。							



		Depth: completely cover the termination					
		Depth: completely cover the termination					
Resistance to Soldering Heat		Temperature (°C) Time(s) Temperature ramp/immersion and emersion rate heat cycles					
		260 ±5 (solder temp) 10 ±1 25mm/s ±6 mm/s 1					
Terminal Strength	Appearance: No damage. Impedance: within±15% of initial value Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value e	Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles With the component mounted on a PCB with the device to be tested apply a force(>0805:1kg , <=0805:0.5kg)to the side of a device being tested. This force shall be applied for 60 +1 seconds. Also the force shall be applied gradually as not to apply a shock to the component being tested. DUT wide thickness shear force					

Note: When there are questions concerning measurement result: measurement shall be made after 48 ± 2 hours of recovery under the standard condition.